


Search Notes 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/607,185		PATTON ET AL.	
	Examiner		Art Unit	
	David C. Reese		3677	

SEARCHED			
Class	Subclass	Date	Examiner
updated		5/1/2008	DR
283	114		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Forward and backward citations from various hits from the listed search	6/13/2005	DR
Used past search (reference cited), prior art, etc. from parent case examined by Thomas Ho		
Text search under "near-field optics"		
STIC Search from EIC		
See Submitted Search history	1/18/07	DR
For extensive text search		
F/B citations From above hits		
Google Search		

Consulted with Martin
Angebranntdt 5/1/2008 DR